

<b>Notice of References Cited</b>	Application/Control No. 10/662,407	Applicant(s)/Patent Under Reexamination EKBERG ET AL.	
	Examiner Huy C. Ho	Art Unit 2617	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,604,140	08-2003	Beck et al.	709/226
*	B	US-2005/0058149	03-2005	Howe, Wayne Richard	370/428
	C	US-			
	D	US-			
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	F	US-			
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	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

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